Ensure the Bondability of Your Wire

SurfaceScan® SERA

Sequential Electrochemical Reduction Analyzer



Copper and Silver wires are rapidly gaining a foothold as an interconnection material in semiconductor packaging applications due to some advantages over gold. These advantages include up to 90% cost reduction, superior electrical and thermal conductivity, less intermetallic growth, greater reliability of the bond at elevated temperatures and higher mechanical stability. One of the disadvantages of Copper and Silver wires is that they tends to undergo oxidation at relatively low temperatures. Sequential Electrochemical Reduction Analysis (SERA) can measure copper oxidation and thus help study and optimization of wirebonding processes utilizing copper wire.

QC-200 was specifically developed to measure Copper and Silver wires 15-100 µm in diameter. With a detection limit down to 10 Angstrom, this system can easily detect native oxide on the wire and subsequent oxidation levels due to ambient exposure. QC-200 is also capable or distinguishing between CuO, Cu₂O, and CuS. These attributes make SurfaceScan QC-200 an ideal tool for quality control of incoming Copper or Silver wires, pre-bond, handling and storage of spools.





SurfaceScan® SERA

An invaluable surface analyzer for detection of reducible species on Copper and Silver wire

Features and Benefits:

- Quantitatively detect Oxides and other reducible species
- Analyze Copper and Silver wire diameters between 0.8mil 3mil
- Measures type and thickness of Oxides or Sulfides
- Current density range 10-1000 mA/cm²
- Analyzer footprint including stand and printer 6ft² (0.557m²)
- Nitrogen used for de-aeration (pre-purified 99.998% or better, moisture < 3 ppm, Oxygen < 5 ppm)
- Borate buffer solution used (Boric acid + Sodium tetraborate, pH range 8.3-8.5)
- Superior accuracy and precision
- Supports wire spools and modified electrical connectors
- Computer specs Intel Pentium or better, Windows XP or better

Typical Applications:

- Detect and measure Oxides and other reducible species on wire surface
- Study the mechanism and rate of Oxide growth in different temperatures and atmospheres (air, forming gas, Nitrogen, etc.)

<u>Taiwan</u>

Great for wire manufacturers, assemblers, and wirebonders

Backed by ECI Global Support

For additional information and specifications, call or visit us online:

email: info@ecitechnology.com website: www.ecitechnology.com

Headquarters - United States 60 Gordon Drive, Totowa, NJ 07512 U.S.A.

ECI Technology International Corp.

South Korea

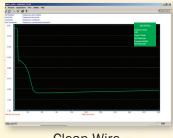
Tel: 82-31-262-8503

3F Leaders Tower, Wongomae-ro 12,

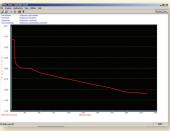
Giheung-gu, Yongin-city, Gyeonggi-do 17086,

ECI International, Inc. Taiwan Branch 6F.-1, No. 81, Shuili Road Hsinchu City, 30059, R.O.C Tel: 973•890•1114 Fax: 973•890•1118 Tel: 011-886-03-5735899 Korea

Japan ECI Japan, Inc. Meguro Building, 7F, 3-22-5 Shin-Yokohama, Kohoku, Kanagawa Japan 222-0033 Tel: 81-45-620-4661



Clean Wire



Oxidized Wire



Wire Exposed to Heat for 24 Hrs

